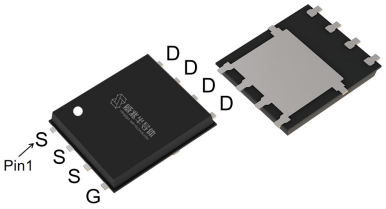
V_{DS}	120	V
$R_{DS(on),TYP}$@ V_{GS}=10V	6.5	mΩ
I_D	57	A

Features

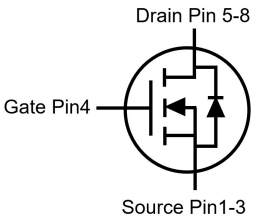
- Enhancement mode
- VitoMOS® Ⅱ Technology
- 100% Avalanche Tested,100% Rg Tested

PDFN5060X



Pb-Free RoHS HF Halogen-Free

Part ID	Package Type	Marking	Packing
VSP007N12HS-G	PDFN5060X	007N12H	3000pcs/Reel



Maximum ratings, at T_A=25 °C, unless otherwise specified

Symbol	Parameter		Rating	Unit
$V_{(BR)DSS}$	Drain-Source breakdown voltage		120	V
V_{GS}	Gate-Source voltage		±20	V
I_S	Diode continuous forward current	T_C = 25°C	50	A
I_D	Continuous drain current @VGS=10V	T_C = 25°C	57	A
I_D	Continuous drain current @VGS=10V	T_C = 100°C	36	A
I_{DM}	Pulse drain current tested ①	T_C = 25°C	228	A
I_{DSM}	Continuous drain current @VGS=10V	T_A = 25°C	13	A
		T_A = 70°C	10	A
EAS	Avalanche energy, single pulsed ②		676	mJ
P_D	Maximum power dissipation ③	T_C = 25°C	50	W
		T_C = 100°C	20	W
P_{DSM}	Maximum power dissipation ④	T_A = 25°C	2.6	W
		T_A = 70°C	1.7	W
T_{STG},T_J	Storage and Junction Temperature Range		-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typical	Max	Unit
$R_{\theta JC}$	Thermal Resistance, Junction-to-Case ⑤	2.1	2.5	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient ⑥	40	48	°C/W

Electrical Characteristics

Symbol	Parameter	Condition	Min.	Typ.	Max.	Unit
Static Electrical Characteristics @ T_j = 25°C (unless otherwise stated)						
$V_{(BR)DSS}$	Drain-Source Breakdown Voltage	V_{GS}=0V, I_D=250μA	120	--	--	V
I_{DSS}	Zero Gate Voltage Drain Current(Tj=25℃)	V_{DS}=120V,V_{GS}=0V	--	--	1	μA
	Zero Gate Voltage Drain Current(Tj=125℃)⑦	V_{DS}=120V,V_{GS}=0V	--	--	100	μA
I_{GSS}	Gate-Body Leakage Current	V_{GS}=±20V,V_{DS}=0V	--	--	±100	nA
$V_{GS(th)}$	Gate Threshold Voltage	V_{DS}=V_{GS},I_D=250μA	2.4	2.9	3.4	V
$R_{DS(on)}$	Drain-Source On-State Resistance ⑧	V_{GS}=10V, I_D=40A	--	6.5	8.5	mΩ
		Tj=100℃ ⑦	--	8.8	--	mΩ
Dynamic Electrical Characteristics @ T_j= 25°C (unless otherwise stated)						
Ciss	Input Capacitance ⑦	V_{DS}=60V,V_{GS}=0V, f=1MHz	2040	4080	7140	pF
Coss	Output Capacitance ⑦		285	570	1000	pF
Crss	Reverse Transfer Capacitance ⑦		10	20	40	pF
Rg	Gate Resistance	f=1MHz	0.2	1.4	2.8	Ω
Qg	Total Gate Charge ⑦	V_{DS}=60V,I_D=40A, V_{GS}=10V	--	66	116	nC
Qgs	Gate-Source Charge ⑦		--	17	30	nC
Qgd	Gate-Drain Charge ⑦		--	19	38	nC
Switching Characteristics ⑦						
Td(on)	Turn-on Delay Time	V_{DD}=60V, I_D=40A, R_G=3.9Ω, V_{GS}=10V	--	16	--	ns
Tr	Turn-on Rise Time		--	39	--	ns
Td(off)	Turn-Off Delay Time		--	45	--	ns
Tf	Turn-Off Fall Time		--	30	--	ns
Source- Drain Diode Characteristics@ T_j = 25°C (unless otherwise stated)						
V_{SD}	Forward on voltage	I_{SD}=40A,V_{GS}=0V	--	0.87	1	V
Trr	Reverse Recovery Time ⑦	V_{DD}=60V, I_{sd}=40A, V_{GS}=0V di/dt=100A/μs	--	100	200	ns
Qrr	Reverse Recovery Charge ⑦		--	301	602	nC

NOTE:

① Single pulse; pulse width ≤ 100μs.

② This value is based on starting T_J = 25°C, L = 0.5mH, R_G = 25Ω, I_{AS} = 52A, V_{GS} =10V； 100% FT tested at L = 0.5mH, I_{AS} = 29A.

③ The power dissipation Pd is based on Tj(max), using junction-to-case thermal resistance RθJC.

④ The power dissipation Pdsm is based on Tj(max), using junction-to-ambient thermal resistance RθJA.

⑤ These tests are performed respectively with the device mounted on a 1 in2 pad and a minimum pad of 2oz. Copper FR-4 board in a still air environment with TA=25°C, using Transient Dual Interface method to acquire RθJC.

⑥ These tests are performed with the device mounted on 1 in2 FR-4 board with 2oz. Copper, in a still air environment with TA=25°C.

⑦ Guaranteed by design, not subject to production testing.

⑧ Pulse width ≤ 380μs; duty cycle≤ 2%.

Typical Characteristics

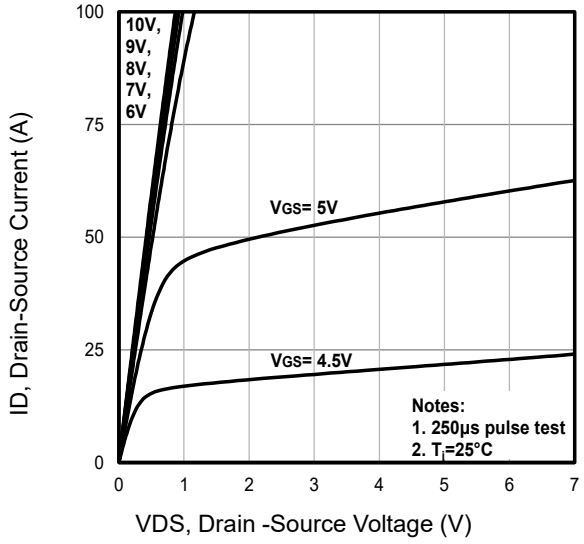


Fig1. Typical Output Characteristics

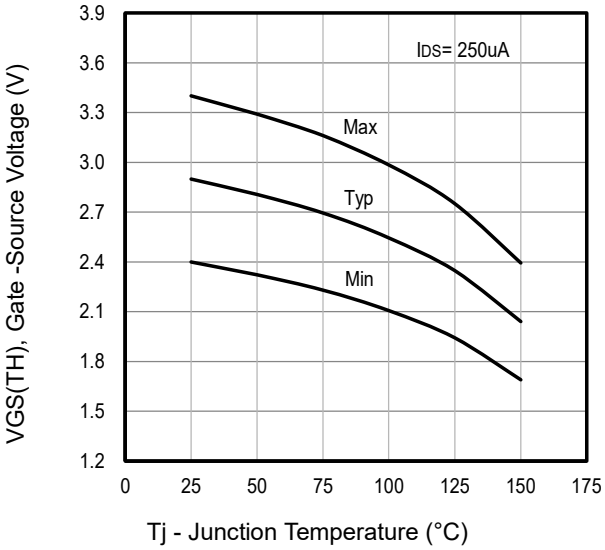


Fig2. Typical $V_{GS(TH)}$ Gate -Source Voltage Vs. Tj

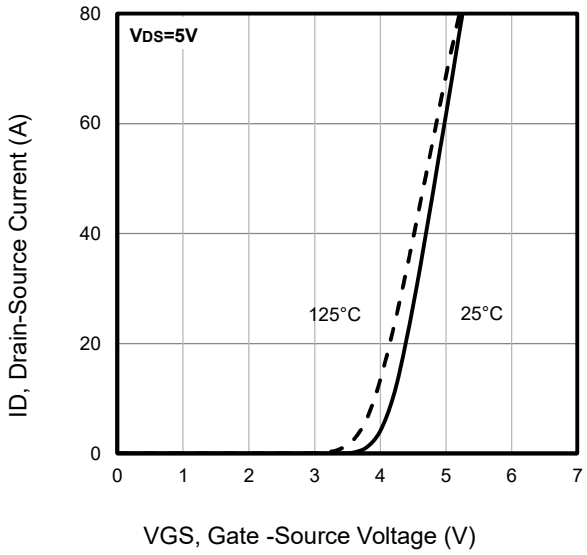


Fig3. Typical Transfer Characteristics

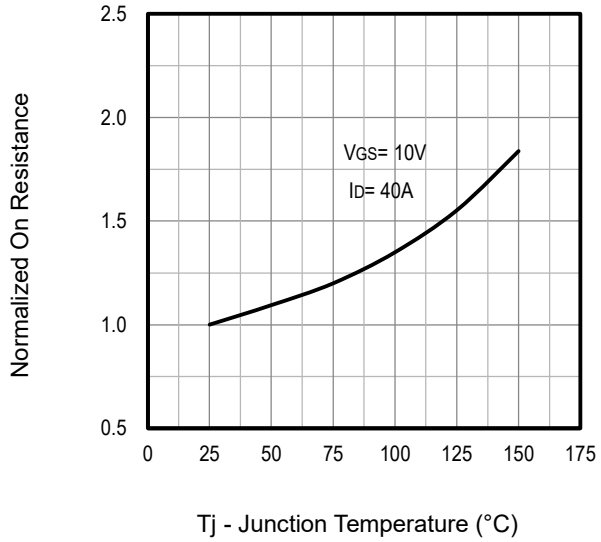


Fig4. Typical Normalized On-Resistance Vs. Tj

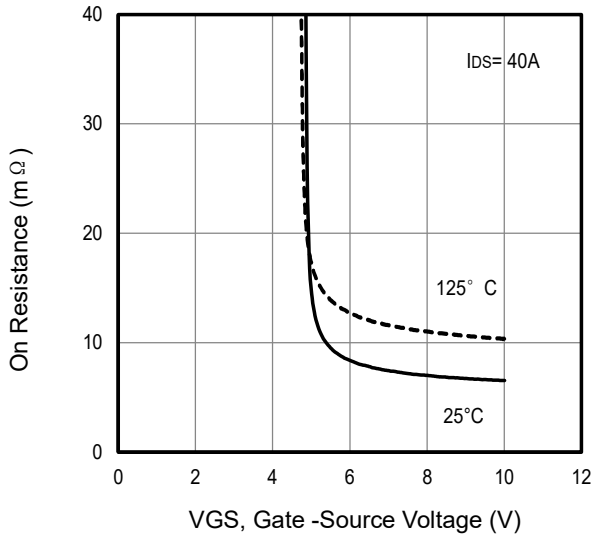


Fig5. Typical On Resistance Vs Gate -Source Voltage

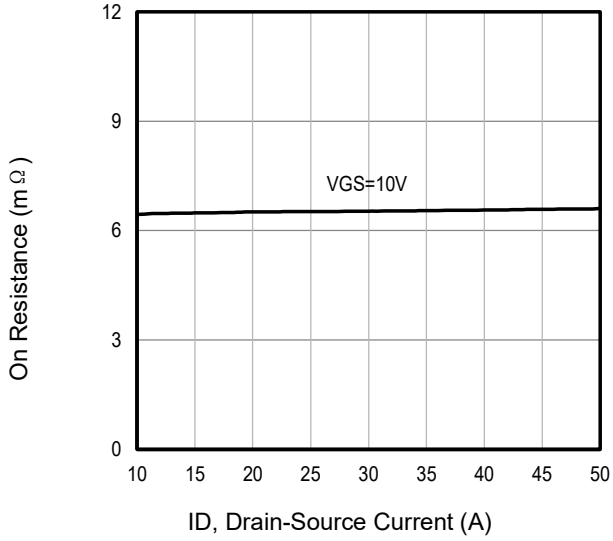


Fig6. Typical On Resistance Vs Drain Current

Typical Characteristics

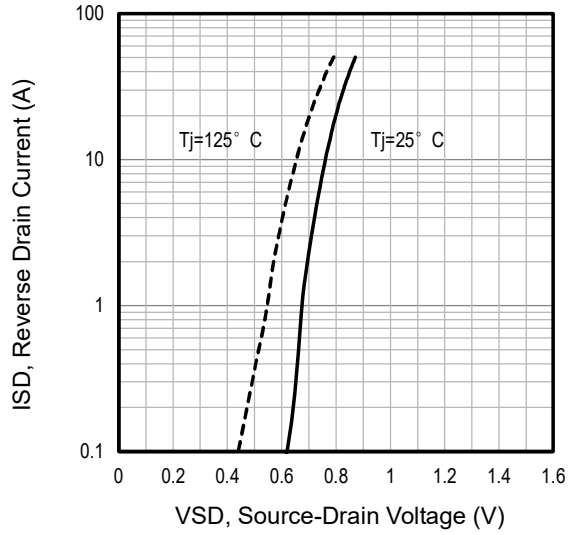


Fig7. Typical Source-Drain Diode Forward Voltage

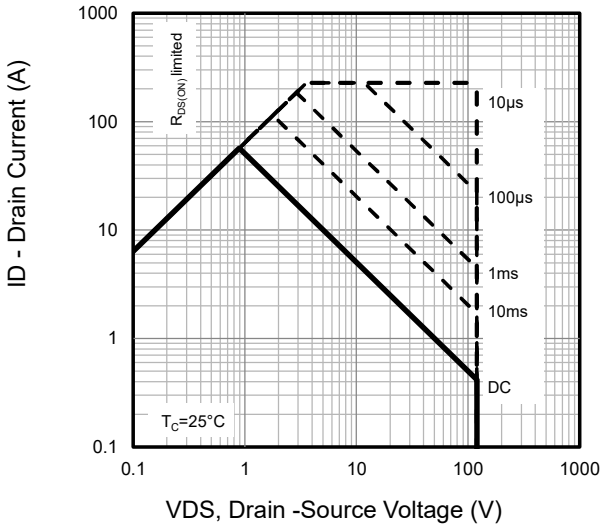


Fig8. Maximum Safe Operating Area

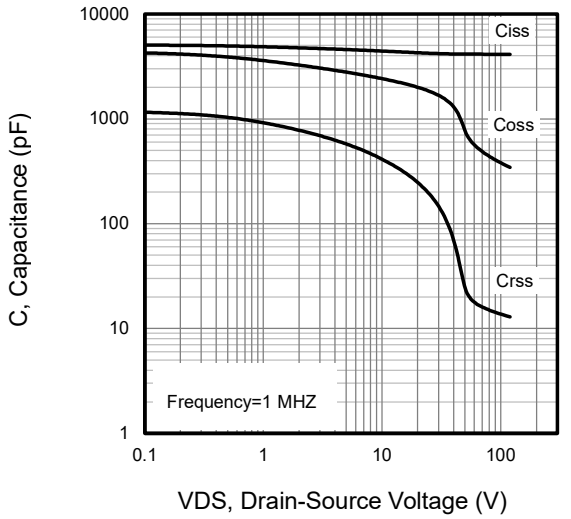


Fig9. Typical Capacitance Vs. Drain-Source Voltage

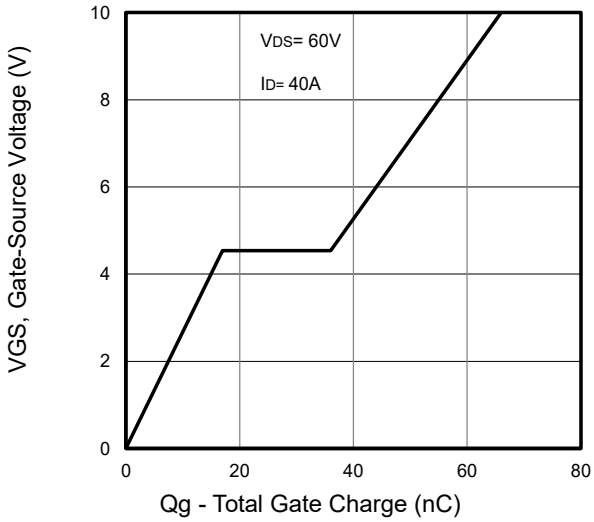


Fig10. Typical Gate Charge Vs. Gate-Source Voltage

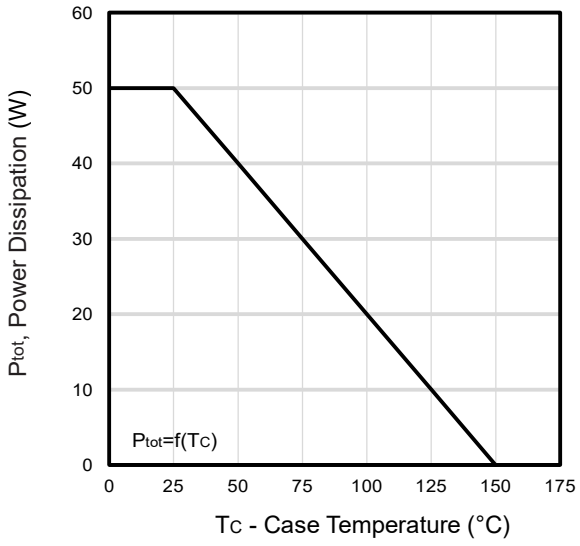


Fig11. Power Dissipation Vs. Case Temperature

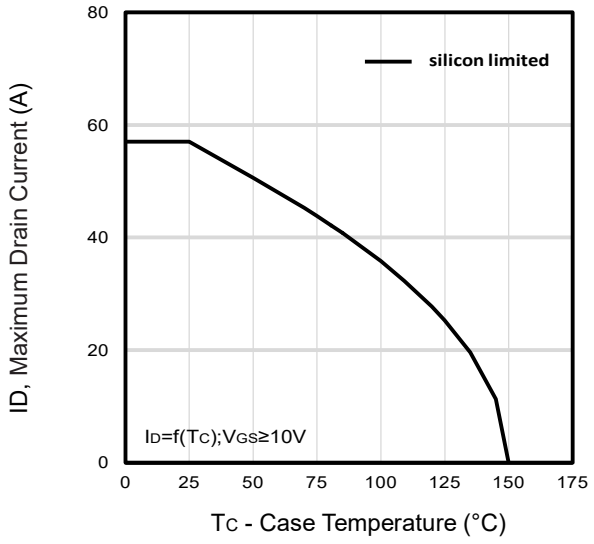


Fig12. Maximum Drain Current Vs. Case Temperature

Typical Characteristics

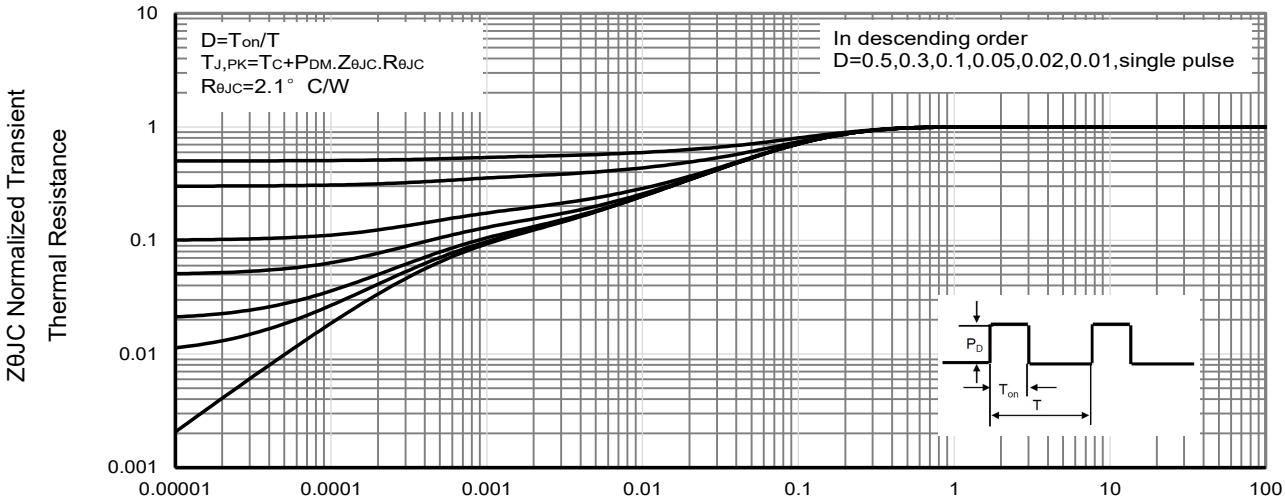


Fig13 . Normalized Maximum Transient Thermal Impedance

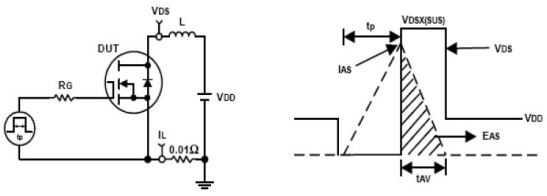


Fig14. Unclamped Inductive Test Circuit and waveforms

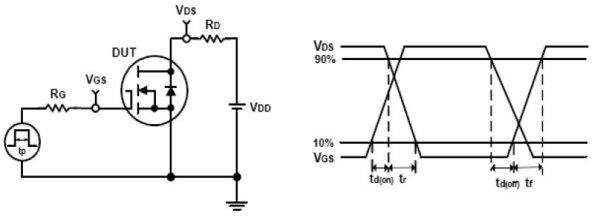
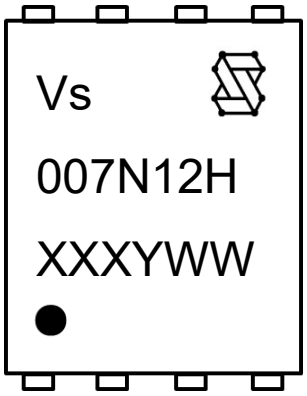


Fig15. Switching Time Test Circuit and waveforms

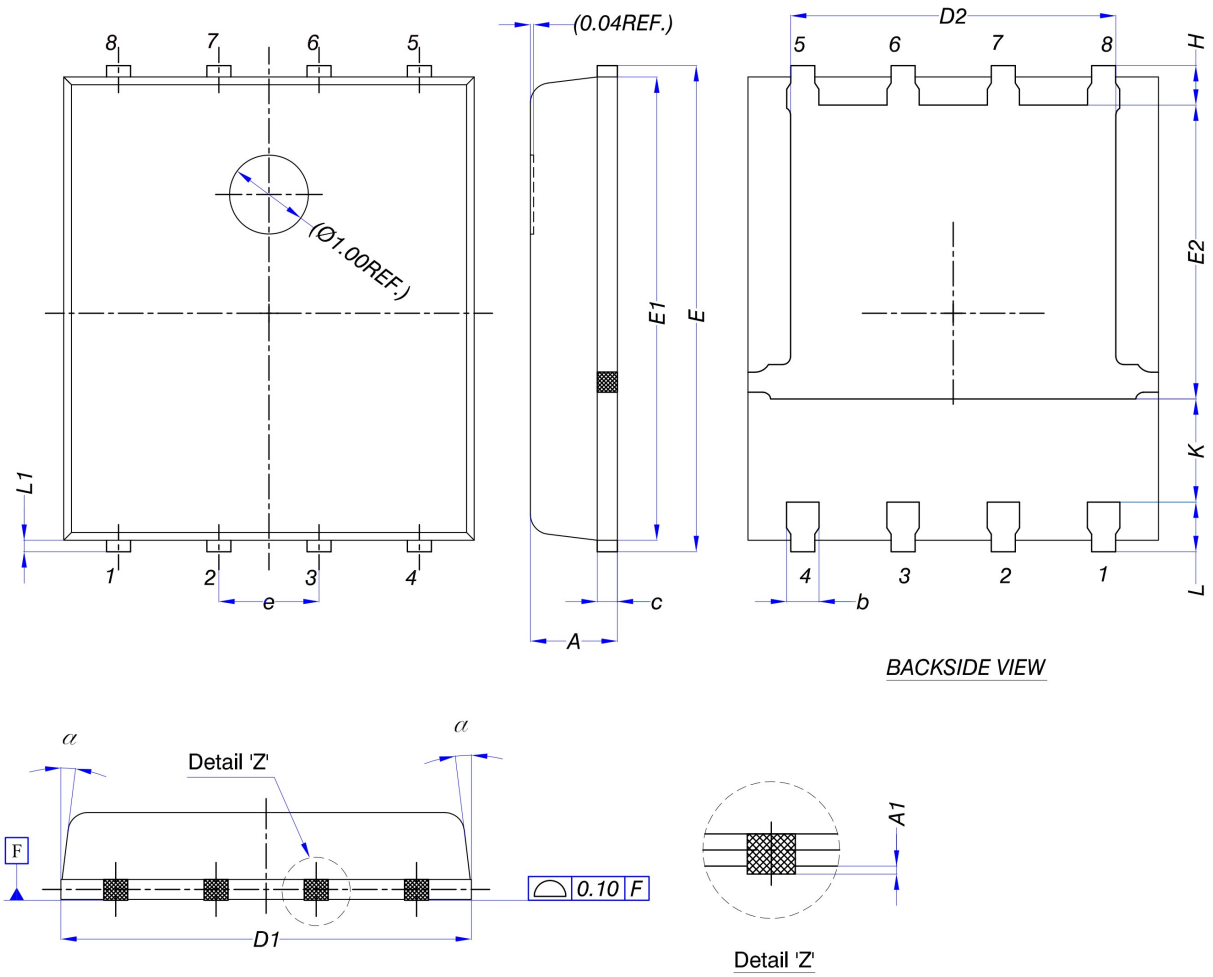
Marking Information



1st line: Vergiga Code（Vs）， Vergiga Logo
2nd line: Part Number（007N12H）
3rd line: Date code （XXXYWW）
XXX: Wafer Lot Number Code, code changed with Lot Number
Y: Year Code，refer to table below
WW: Week Code (01 to 53)

Code	C	D	E	F	G	H	J	K	L	M	N	P	Q	R	S	T
Year	2015	2016	2017	2018	2019	2020	2021	2022	2023	2024	2025	2026	2027	2028	2029	2030

PDFN5060X Package Outline Data



Symbol	DIMENSIONS (unit : mm)		
	Min	Typ	Max
A	1.00	1.10	1.20
A1	0.00	--	0.05
b	0.30	0.40	0.50
c	0.20	0.25	0.30
D1	5.00	5.20	5.40
D2	3.80	4.10	4.25
E	5.95	6.15	6.35
E1	5.66	5.86	6.06
E2	3.52	3.72	3.92
e	1.27 BSC		
H	0.40	0.50	0.60
K	1.10	--	--
L	0.50	0.60	0.70
L1	0.08	0.15	0.22
α	0°	--	12°

Notes:

1. Refer to JEDEC MO-240 variation AA.
2. Dimensions "D1" and "E1" do NOT include mold flash protrusions or gate burrs.
3. Dimensions "D1" and "E1" include interterminal flash or protrusion. Interterminal flash or protrusion shall not exceed 0.25mm per side.

Customer Service

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